


<b>Search Notes</b>  	<b>Application/Control No.</b>  10566679	<b>Applicant(s)/Patent Under Reexamination</b>  PLOUET ET AL.
	<b>Examiner</b>  JON M LOCKARD	<b>Art Unit</b>  1647

SEARCHED			
Class	Subclass	Date	Examiner
NONE		5/26/08	JML

SEARCH NOTES		
Search Notes	Date	Examiner
STIC Search of SEQ ID NO:12. See sequence search results in SCORE.	5/2/08	JML
EAST (USPAT, US-PGPUB, EPO, DERWENT): See attached search history.	5/26/08	JML
STN (MEDLINE, SCISEARCH, EMBASE, BIOSIS): See attached search history.	5/26/08	JML
PALM: Inventor search.	5/26/08	JML

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner